


<b>Search Notes</b>  	<b>Application/Control No.</b>  10532253	<b>Applicant(s)/Patent Under Reexamination</b>  STAMP, KEVIN
	<b>Examiner</b>  JENNER YEHL	<b>Art Unit</b>  4118

SEARCHED			
Class	Subclass	Date	Examiner
604	68	11/17/2008	JY
	18	11/18/2008	JY
	187, 15, 16, 18, 72	11/19/2008	JY
	63, 6.11, 6.12, 36, 63, 70, 118, 124, 137, 134	11/20/2008	JY
	240, 500, 131	11/25/2008	JY
	533, 538	11/26/2008	JY
	432	12/2/2008	JY

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search and IDS search	11/13/2008	JY
Spoke with Chris Koharski about potential allowable subject matter	11/25/2008	JY

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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